

FDM2509NZ

Monolithic Common Drain N-Channel 2.5V Specified PowerTrench® MOSFET

General Description

This dual N-Channel MOSFET has been designed using Fairchild Semiconductor's advanced Power Trench process to optimize the $R_{\text{DS}(\text{ON})}$ @ V_{GS} = 2.5v on special MicroFET lead frame with all the drains on one side of the package.

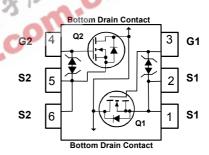
Applications

• Li-Ion Battery Pack

Features

- 8.7 A, 20 V $R_{DS(ON)}$ = 18 m Ω @ V_{GS} = 4.5 V $R_{DS(ON)}$ = 24 m Ω @ V_{GS} = 2.5 V
- ESD protection diode (note 3)
- Low Profile 0.8mm maximum in the new package MicroFET 2x5 mm





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V_{DSS}	Drain-Source Voltage		20	V
V_{GSS}	Gate-Source Voltage		±12	V
I _D	Drain Current - Continuous	(Note 1a)	8.7	А
	– Pulsed		30	
P _D	Power Dissipation (Steady State)	(Note 1a)	2.2	W
		(Note 1b)	0.8	
T_J , T_{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

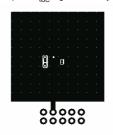
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	55	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (Drain)	2	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
2509Z	FDM2509NZ	7"	12mm	3000 units

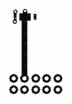
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics		1	l		
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$	20			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		12		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 16 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			1	μА
I_{GSS}	Gate-Body Leakage,	$V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μΑ
On Chara	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	0.6	0.9	1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25 $$ C		-3		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 8.7 \text{ A}$ $V_{GS} = 4.0 \text{ V}, I_D = 8.5 \text{ A}$ $V_{GS} = 3.1 \text{ V}, I_D = 8.1 \text{ A}$ $V_{GS} = 2.5 \text{ V}, I_D = 7.6 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 8.7 \text{ A}, T_J = 125^{\circ}\text{C}$	9-	13 13.5 15.5 18 18.4	18 19 21 24 25	mΩ
g _{FS}	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 8.7 \text{ A}$		36		S
Dynamic	Characteristics	2 13	CI			
C _{iss}	Input Capacitance	V _{DS} = 10 V, V _{GS} = 0 V,		1200		pF
Coss	Output Capacitance	f = 1.0 MHz		320		pF
C _{rss}	Reverse Transfer Capacitance			185		pF
R _G	Gate Resistance	$V_{GS} = 50 \text{mV}, f = 1.0 \text{ MHz}$		2		Ω
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 10 \text{ V}, \qquad I_{D} = 1 \text{ A},$		11	20	ns
t _r	Turn-On Rise Time	$V_{GS} = 4.5 \text{ V}, R_{GEN} = 6 \Omega$		15	27	ns
$t_{d(off)}$	Turn-Off Delay Time			27	43	ns
t _f	Turn-Off Fall Time			12	22	ns
Q _g	Total Gate Charge	$V_{DS} = 10 \text{ V}, \qquad I_{D} = 8.7 \text{ A},$		12	17	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 4.5 V		2		nC
Q_{gd}	Gate-Drain Charge			4		nC
Drain-Sc	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Source				1.8	Α
V_{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 1.8 \text{ A} \text{(Note 2)}$		0.7	1.2	V
t _{rr}	Diode Reverse Recovery Time	I _F = 8.7 A,		20		nS
Q _{rr}	Diode Reverse Recovery Charge	$dI_F/dt = 100 A/\mu s$		6.4		nC

Notes:
1. R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $\rm R_{\theta JC}$ is guaranteed by design while $\rm R_{\theta CA}$ is determined by the user's board design.



- a) 55°C/W when mounted on a 1in² pad of 2 oz copper
 - Scale 1 : 1 on letter size

paper



- b) 145°C/W when mounted on a minimum pad of 2 oz copper
 2. Pulse Test: Pulse Width < 300 μs, Duty Cycle < 2.0%
 3. The diode connected between the gate and the source serves only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics

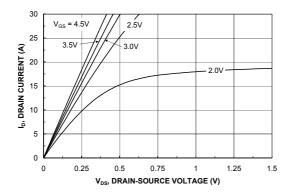
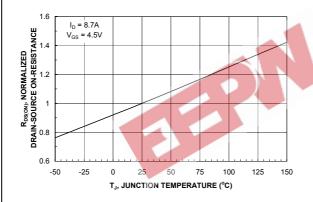


Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.



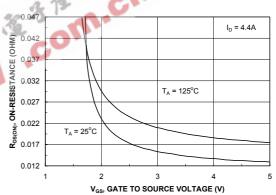
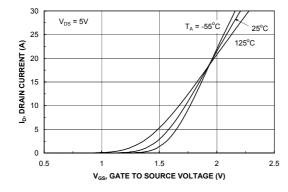


Figure 3. On-Resistance Variation with Temperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



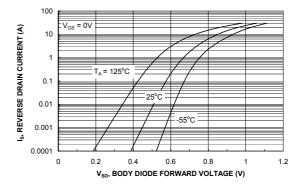
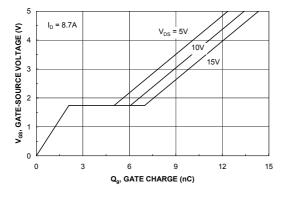


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



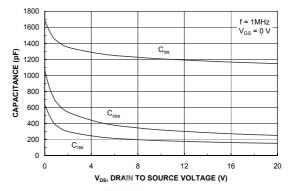
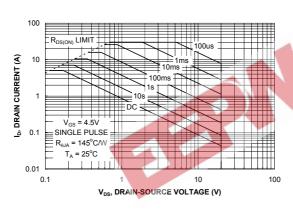


Figure 7. Gate Charge Characteristics.





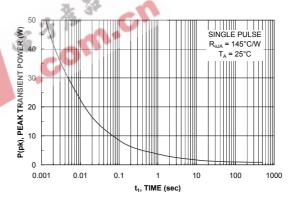


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

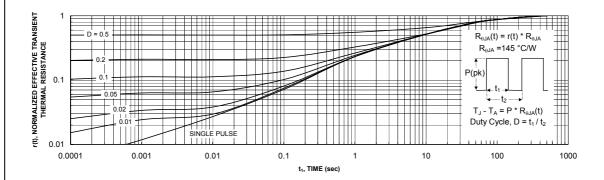
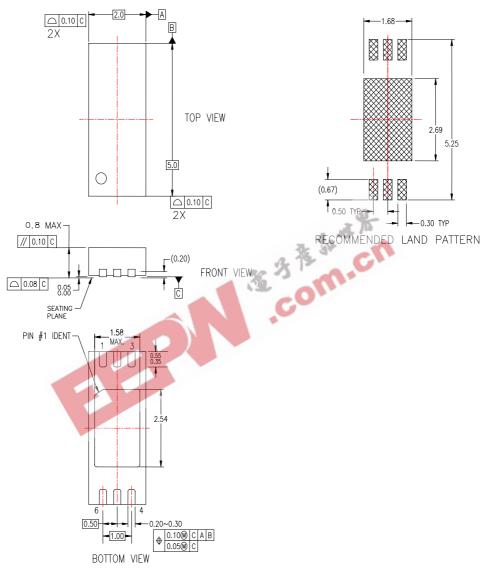


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

Dimensional Outline and Pad Layout



NOTES:

- A. NON-STANDARD JEDEC REGISTERED MOLDED PACKAGE OUTLINE.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994

MLP06XrevA

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